Search Notes

Application/Control No.	Applicant(s)/Patent un Reexamination	der	
10/667,790	TOGAWA, YOSHIFU	TOGAWA, YOSHIFUSA	
Examiner	Art Unit		
Eric Chang	2116		

SEARCHED					
Class	Subclass	Date	Examiner		
713	320	10/19/2007	EC		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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